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| Notice of Allowability | Application No. | Applicant(s) |
| | 10/621,002 | DE JONG ET AL. |
| | Examiner Craig Miller | Art Unit 2857 |

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address--

All claims being allowable, PROSECUTION ON THE MERITS/IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTO-85) or other appropriate communication will be mailed in due course. **THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS.** This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.

1. This communication is responsive to pre-amendment filed 7/16/03.
2. The allowed claim(s) is/are 2-10 now renumbered 2-9 and 1, respectively.
3. The drawings filed on 16 July 2003 are accepted by the Examiner.
4. Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
 - a) All
 - b) Some*
 - c) None
 1. Certified copies of the priority documents have been received.
 2. Certified copies of the priority documents have been received in Application No. _____.
 3. Copies of the certified copies of the priority documents have been received in this national stage application from the International Bureau (PCT Rule 17.2(a)).

* Certified copies not received: _____.

Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application.
THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.

5. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.
6. CORRECTED DRAWINGS (as "replacement sheets") must be submitted.
 - (a) including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached
 - 1) hereto or 2) to Paper No./Mail Date _____.
 - (b) including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No./Mail Date _____.

Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the header according to 37 CFR 1.121(d).
7. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.

Attachment(s)

1. Notice of References Cited (PTO-892)
2. Notice of Draftsperson's Patent Drawing Review (PTO-948)
3. Information Disclosure Statements (PTO-1449 or PTO/SB/08),
Paper No./Mail Date _____.
4. Examiner's Comment Regarding Requirement for Deposit
of Biological Material
5. Notice of Informal Patent Application (PTO-152)
6. Interview Summary (PTO-413),
Paper No./Mail Date _____.
7. Examiner's Amendment/Comment
8. Examiner's Statement of Reasons for Allowance
9. Other _____.

1. Claims 2-10, now renumbered 2-9 and 1, respectively, are allowable over the prior art of record.

2. The following is an examiner's statement of reasons for allowance:

The prior art of record neither discloses nor suggests normal and test interconnects wherein the test input unit includes at least one combinatorial circuit with at least two inputs and a function output, thus testing particular I/O nodes.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "*Comments on Statement of Reasons for Allowance*."

3. The prior art made of record but not relied upon is deemed pertinent to applicant's disclosure.

Williams (EP pub. 0,588,507 A2) discloses testing IC interconnections.

Thatcher *et al.* (GB 2,278,689 A) discloses measuring passive elements during IC testing.

Whetsel (5,103,450) discloses test protocols for IC testing.

Hunter (5,416,409) discloses IC interconnect integrity.

Muris *et al.* (5,781,559) discloses a testable circuit with separate test mode interconnects.

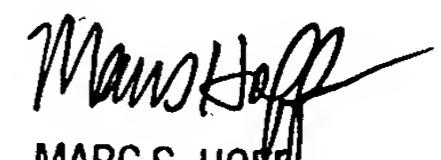
4. Any inquiry concerning this communication or earlier communications from the Examiner should be directed to Craig Steven Miller whose telephone number is (571) 272-2219.

The Examiner can normally be reached on Mondays, Tuesdays and Thursdays from 07:00 am through 4:00 p.m. EDT.

If attempts to reach the Examiner by telephone are unsuccessful, the Examiner's Supervisor, Marc Hoff, can be reached at (571) 272-2216.

Any inquiry of a general nature or relating to the status of this application should be directed to the Group receptionist whose telephone number is (571) 272-2800.

Craig Steven Miller (ss)
21 April 2004


MARC S. HOFF
SUPERVISORY PATENT EXAMINER
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